

General Description

It combines planar MOSFET technology with a low resistance package to provide low $R_{DS(ON)}$.

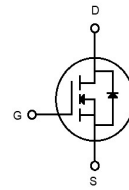
Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

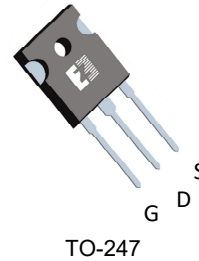
Application

- BLDC Motor driver
- DC-DC
- Load Switch

Product Summary



$V_{DS} = 60V$
 $R_{DS(ON)} = 19m\Omega$
 $I_D = 92A$



Ordering Information:

Part NO.	ZMPA100N06HC
Marking	ZMP100N06H
Packing Information	BULK TUBE
Basic ordering unit (pcs)	400

Absolute Maximum Ratings ($T_A=25^\circ C$, unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Max.	Unit
Drain-Source Voltage	V_{DS}		-	60	V
Gate-Source Voltage ^①	V_{GS}		-20	20	V
Continuous Drain Current	I_D	$V_{GS}=10V, T_C=25^\circ C$	-	92	A
	I_D	$V_{GS}=10V, T_C=75^\circ C$	-	75	A
	I_D	$V_{GS}=10V, T_C=100^\circ C$	-	65	A
Pulsed Drain Current ^①	I_{DM}	Pulsed; $t_p \leq 10 \mu s$; $T_C = 25^\circ C$;	-	368	A
Total Power Dissipation	P_D	$T_C=25^\circ C$	-	417	W
Total Power Dissipation	P_D	$T_A=25^\circ C$	-	3.8	W
Operating Junction Temperature	T_J		-55	175	$^\circ C$
Storage Temperature	T_{STG}		-55	175	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	$L=5mH, V_{GS}=10V, R_g=25\Omega$,	-	4000	mJ
ESD Level (HBM)	CLASS 2				

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	0.36	°C/W
Thermal resistance, junction-ambient	$R_{thJA}^{②}$	-	-	40	°C/W
Soldering temperature	T_{sold}	-	-	260	°C

•Electronic Characteristics (Tj=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	60	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2	2.5	4	V
Drain-Source Leakage Current	I_{DSS}	$V_{GS}=0V, V_{DS}=60V$	-	-	1	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=50A, T_J=25^\circ C$	-	19	23	m Ω
		$V_{GS}=10V, I_D=50A, T_J=175^\circ C$	-	40.7	-	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=5V, I_{SD}=10A$	-	19	-	S
Diode Forward Voltage	V_{FSD}	$V_{GS}=0V, I_{SD}=50A$	-	-	1.3	V

•Dynamic characteristics (Tj=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$f=100KHz, V_{DS}=30V, V_{GS}=0V$	-	3873	-	pF
Output capacitance	C_{oss}		-	971	-	
Reverse transfer capacitance	C_{rss}		-	80	-	
Gate Resistance	R_g	$f=1MHz$	-	2.3	-	Ω
Total gate charge	Q_g	$V_{DD}=30V, I_D=50A, V_{GS}=10V$	-	79.1	-	nC
Gate - Source charge	Q_{gs}		-	16.5	-	
Gate - Drain charge	Q_{gd}		-	21.9	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=10V, V_{DS}=30V, R_G=3.3\Omega, I_D=50A$	-	21	-	ns
Turn-ON Rise time	t_r		-	63	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	80	-	ns
Turn-Off Fall time	t_f		-	28	-	ns
Reverse Recovery Time	t_{rr}	$V_{DD}=50V, di_S/dt=100A/\mu s, I_S=50A$	-	81	-	ns
Reverse Recovery Charge	Q_{rr}		-	215	-	nC

Fig.1 Gate-source voltage as a function of gate charge; Typical values; $T_j=25^\circ\text{C}$

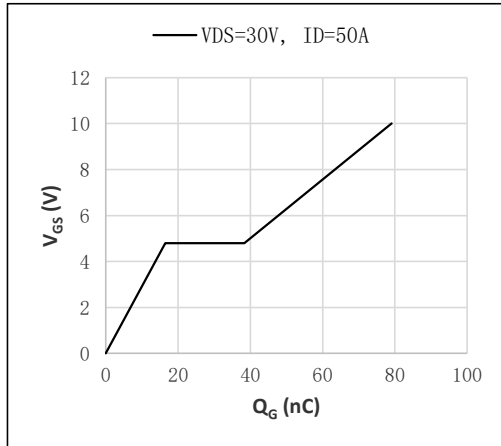


Fig.2 Input, output and reverse transfer capacitances as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$

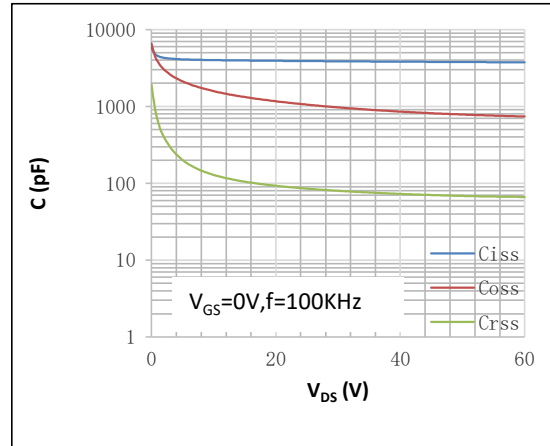


Fig.3 Output characteristics: drain current as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$

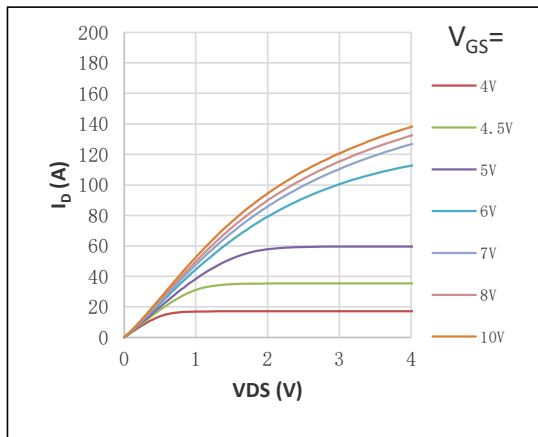


Fig.4 Output characteristics: drain current as a function of drain-source voltage; Typical values: Expanded curve; $T_j=25^\circ\text{C}$

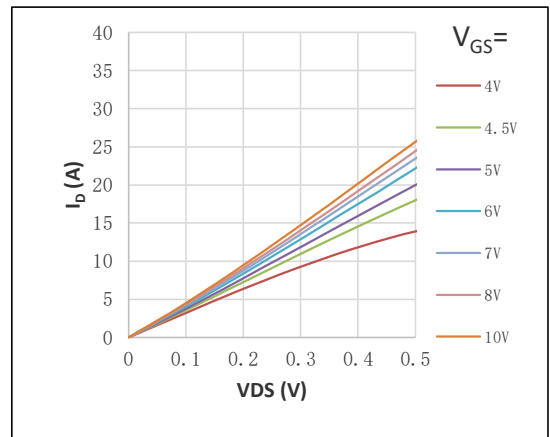


Fig.5 Gate-source threshold voltage as a function of junction temperature; Typical values

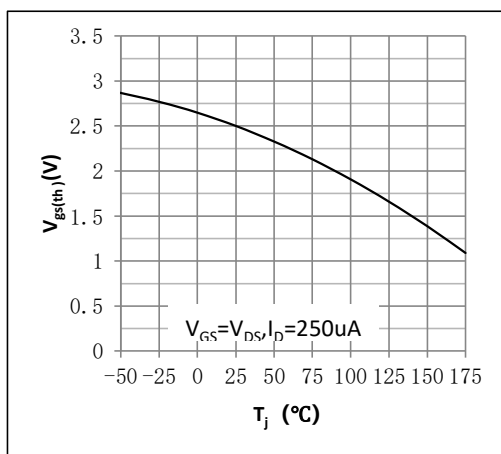


Fig.6 Drain-source on-state resistance as a function of drain current; Typical values; $T_j=25^\circ\text{C}$

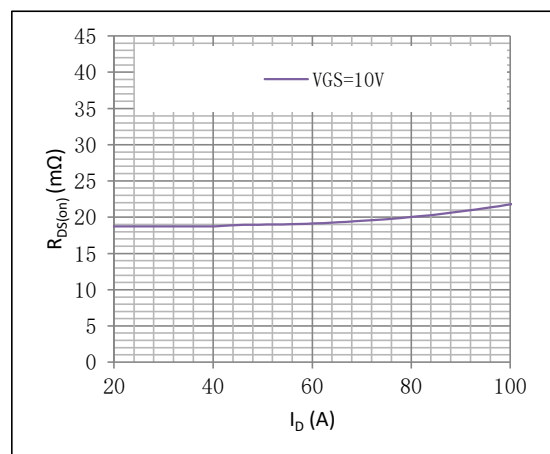


Fig.7 Drain-source on-state resistance as a function of gate-source voltage;Typical values

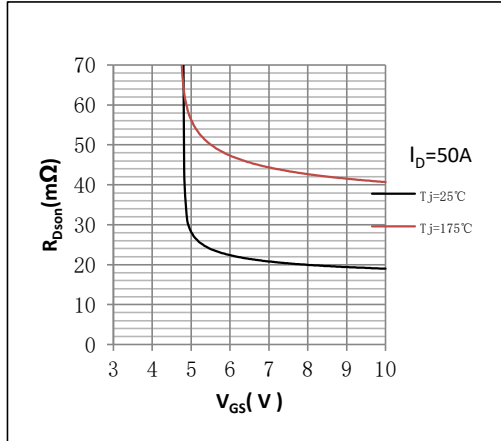


Fig.8 Normalized drain-source on-state resistance factor as a function of junction temperature;Typical values
Normalized On-Resistance= $R_{DS(on)}/R_{DS(on)}(25^{\circ}\text{C})$

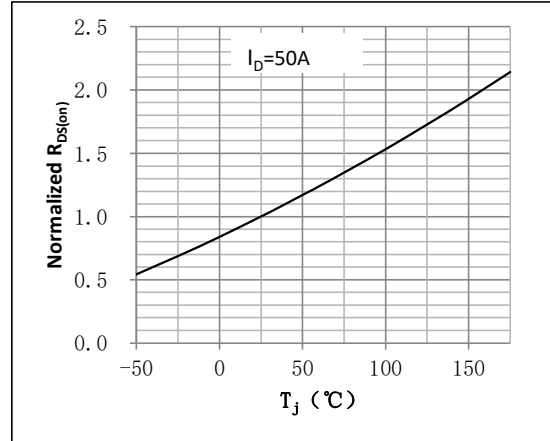


Figure 9. Source (diode forward) current as a function of source-drain (diode forward) voltage ;Typical values

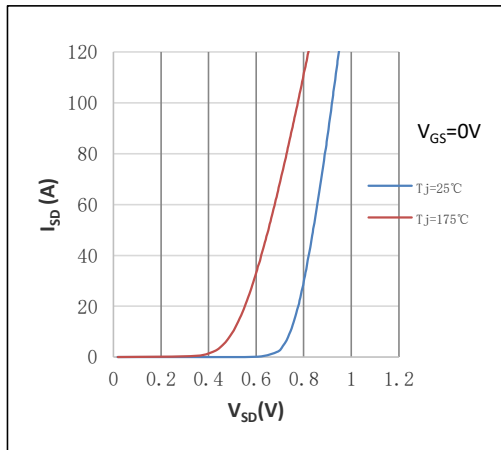


Figure 10. Transfer characteristics: drain current as a function of gate-source voltage;Typical values

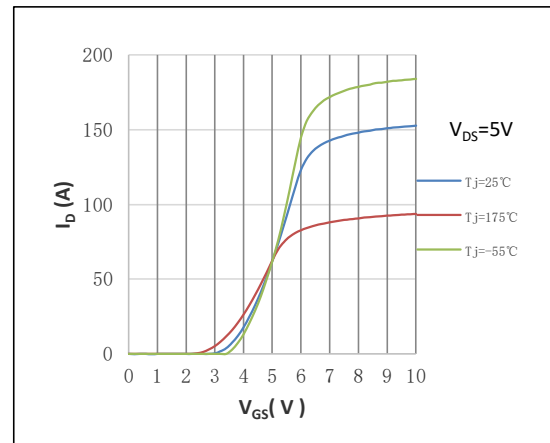


Fig.11 Safe operating area: continuous and peak drain currents as a function of drain-source voltage;Calculative values

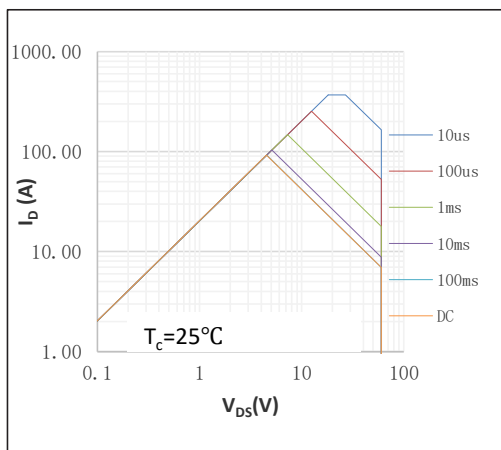


Fig.12 Continuous drain current as a function of case temperature[®];Calculative values

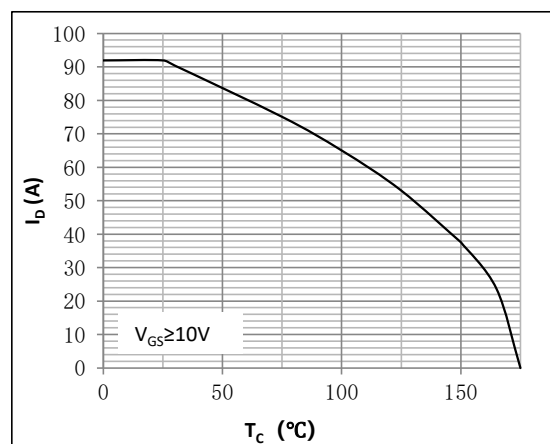


Fig.13 Drain-source breakdown voltage as a function of junction temperature; Typical values
Normalized BVDSS=BVDSS/BVDSS(25°C)

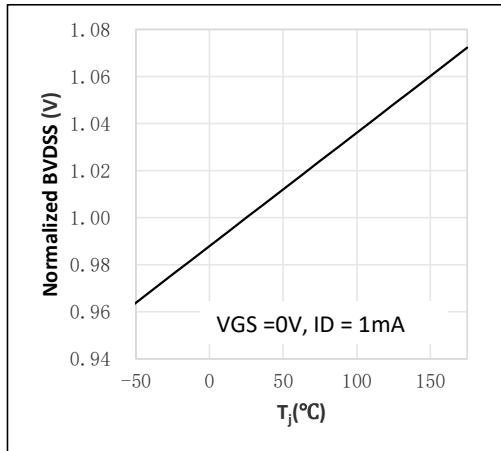


Fig.14 Normalized total power dissipation as a function of case temperature; Calculative values
Normalized Power Dissipation= $P_d/P_d(25^\circ C)$

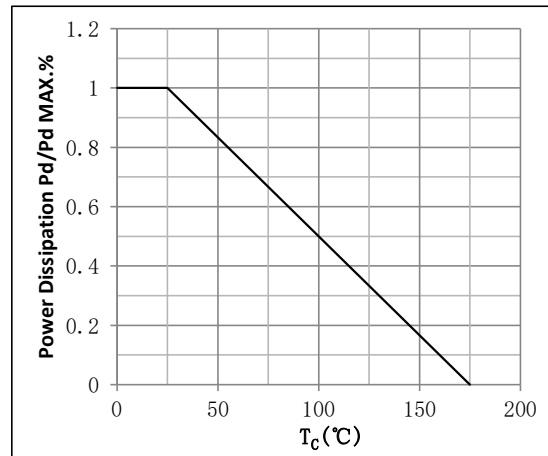
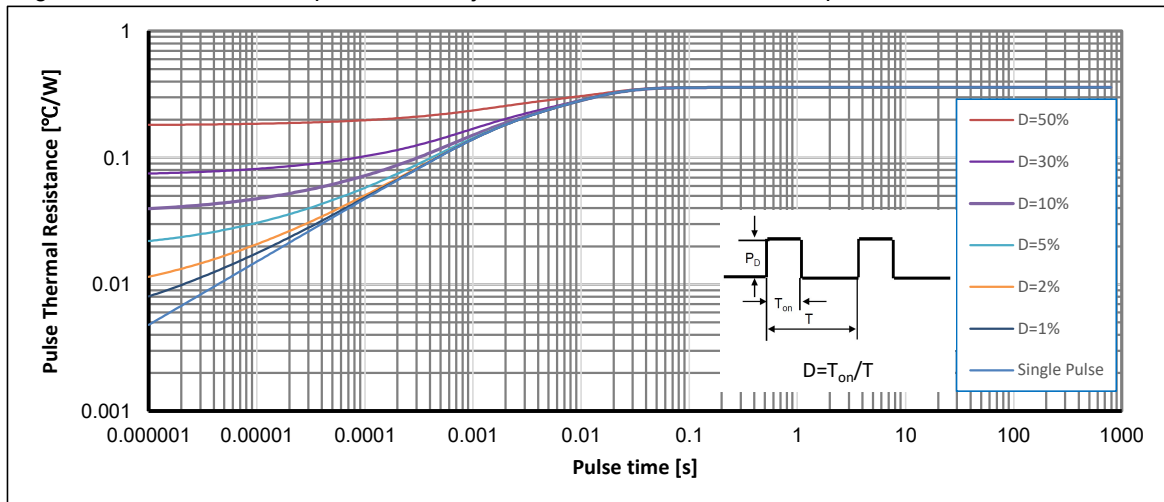
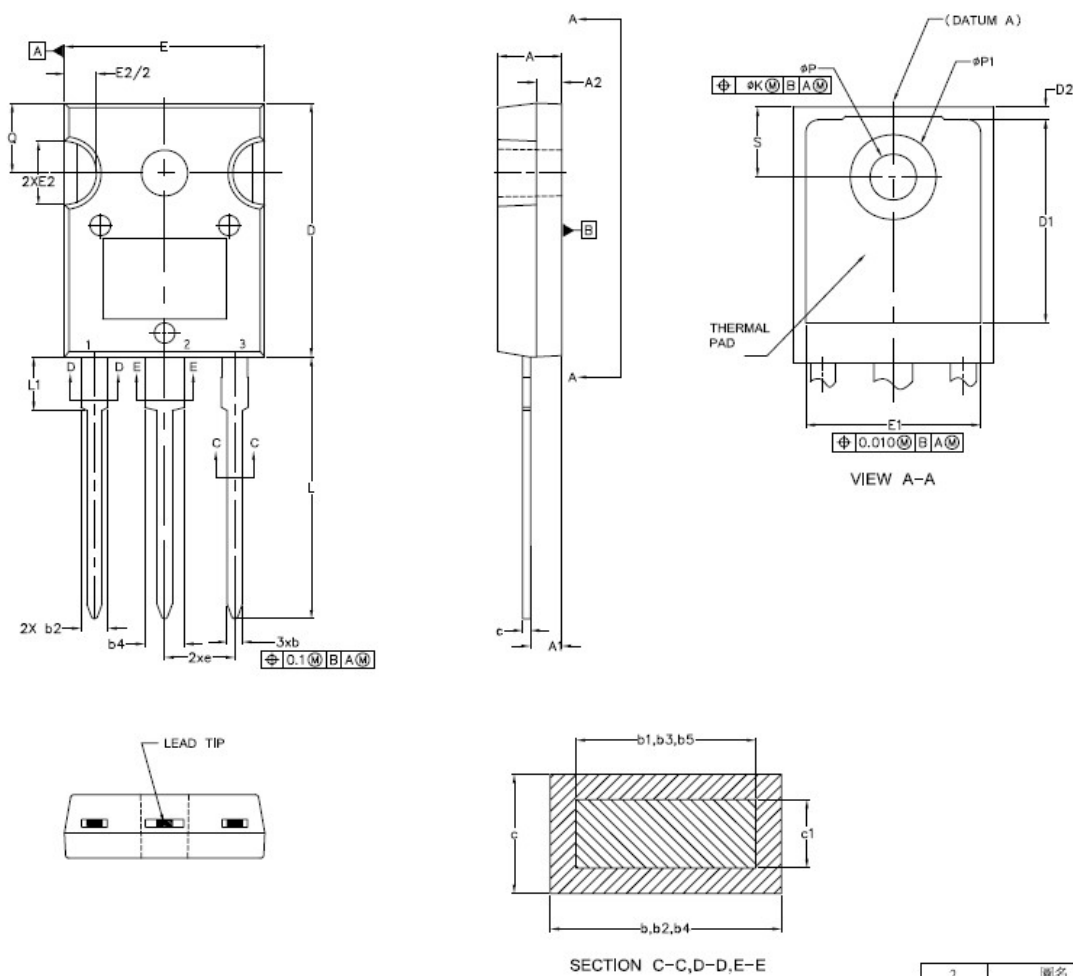


Fig.15 Transient thermal impedance from junction to case as a function of pulse duration; max values



•TO-247 Package Outline



SYMBOLS	DIMENSIONS			
	mm		Inch	
	MIN.	MAX.	MIN.	MAX.
A	4.83	5.13	0.190	0.20
A1	2.21	2.59	0.087	0.102
A2	1.50	2.49	0.059	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.65	2.39	0.065	0.094
b3	1.65	2.34	0.065	0.092
b4	2.59	3.43	0.102	0.135
b5	2.59	3.38	0.102	0.133
c	0.38	0.89	0.015	0.035
c1	0.38	0.84	0.015	0.033
D	19.71	20.70	0.776	0.815
D1	13.08	—	0.515	—
D2	0.51	1.35	0.020	0.053
E	15.29	15.87	0.602	0.625
E1	13.46	—	0.530	—
E2	4.52	5.49	0.178	0.216
e	5.46BSC		0.215BSC	
L	19.57	21.00	0.780	0.827
L1	3.71	4.29	0.146	0.169
φP	3.56	3.66	0.140	0.144
φP1	—	7.39	—	0.291
Q	5.31	5.69	0.209	0.224
S	5.51BSC		0.217BSC	

Note:

- ① Pulse : $V_{GS}=+20V/-20V$, Duty cycle=50%, $T_j=175^{\circ}C$, $t=1000$ hours; For DC , the following test conditions can be passed: $V_{GS}=+20V/-10V$, $T_j=175^{\circ}C$, $t=1000$ hours;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS}=10V$.

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Version	Date	Change
A	2025/5/29	New